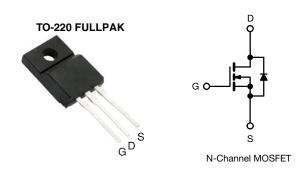
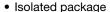


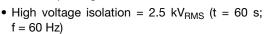
Power MOSFET



PRODUCT SUMMARY					
V _{DS} (V)	60				
R _{DS(on)} (Ω)	V _{GS} = 5.0 V 0.050				
Q _g (Max.) (nC)	35				
Q _{gs} (nC)	7.1				
Q _{gd} (nC)	25				
Configuration	Single				

FEATURES







- Sink to lead creepage distance = 4.8 mm
- · Logic-level gate drive
- R_{DS(on)} specified at V_{GS} = 4 V and 5 V
- · Fast switching
- · Ease of paralleling
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRLIZ34GPbF

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted					
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-source voltage			V_{DS}	60	V
Gate-source voltage			V_{GS}	± 10	7 v
Continuous drain current	Vac at 5.0 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	I _D	20	А
Continuous drain current	V _{GS} at 5.0 V	T _C = 100 °C		14	
Pulsed drain current ^a			I _{DM}	80	
Linear derating factor				0.28	W/°C
Single pulse avalanche energy b			E _{AS}	200	mJ
Maximum power dissipation $T_C = 25 ^{\circ}C$		P_{D}	42	W	
Peak diode recovery dV/dt ^c			dV/dt	4.5	V/ns
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +175	°C	
Soldering recommendations (peak temperature) d	For 10 s		-	300	1
Mounting torque	M3 s	crew		0.6	Nm

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 583 μ H, R_G = 25 Ω , I_{AS} = 20 A (see fig. 12 °)
- c. $I_{SD} \le 30$ A, $dI/dt \le 200$ A/µs, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C
- d. 1.6 mm from case



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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum junction-to-ambient	R _{thJA}	-	65	°C/W	
Maximum junction-to-case (drain)	R _{thJC}	-	3.6	C/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-ssource breakdown voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 250 μA	60	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.070	-	V/°C
Gate-source threshold voltage	V _{GS(th)}	V _{DS} =	· V _{GS} , I _D = 250 μA	1.0	-	2.0	V
Gate-source leakage	I _{GSS}	,	V _{GS} = ± 10 V	-	-	± 100	nA
Zoro goto voltago droip ourrent	1	V _{DS} :	= 60 V, V _{GS} = 0 V	-	-	25	- uA
Zero gate voltage drain current	I _{DSS}	$V_{DS} = 48 V_{s}$	V _{GS} = 0 V, T _J = 150 °C	-	-	250	μΑ
Drain-source on-state resistance	D	V _{GS} = 5.0 V	I _D = 12 A ^b	-	-	0.050	0
Dialii-Source ori-state resistance	R _{DS(on)}	V _{GS} = 4.0 V	I _D = 10 A ^b	-	-	0.070	Ω
Forward transconductance	9 _{fs}	V _{DS} =	= 25 V, I _D = 12 A ^b	12	-	1	S
Dynamic							
Input capacitance	C _{iss}		V _{GS} = 0 V,	-	1600	-	- pF
Output capacitance	C _{oss}]	$V_{DS} = 25 V$,	-	660	-	
Reverse transfer capacitance	C _{rss}] f = 1.	0 MHz, see fig. 5	-	170	-	
Drain to sink capacitance	С		f = 1 MHz	-	12	-	
Total gate charge	Qg			-	-	35	nC
Gate-source charge	Q_{gs}	V _{GS} = 5.0 V	$I_D = 30 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13 ^b	-	-	7.1	
Gate-drain charge	Q_{gd}		goo ngi o ana io	-	-	25	
Turn-on delay time	t _{d(on)}	$V_{DD} = 30 \text{ V, } I_D = 30 \text{ A,}$ $R_G = 6.0 \ \Omega, R_D = 1.0 \ \Omega,$ see fig. 10^b		-	14	-	ns
Rise time	t _r			-	170	-	
Turn-off delay time	t _{d(off)}			-	30	-	
Fall time	t _f			-	56	ı	
Internal drain inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	1	-11
Internal source inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	cs			,			
Continuous source-drain diode current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	20	А
Pulsed diode forward current ^a	I _{SM}			-	-	80	
Body diode voltage	V_{SD}	T _J = 25 °C	$I_{S} = 20 \text{ A}, V_{GS} = 0 \text{ V}^{b}$	-	-	1.6	V
Body diode reverse recovery time	t _{rr}	T 25 °C 1	= 30 A dl/dt = 100 A/vah	-	90	180	ns
Body diode reverse recovery charge	Q_{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 30 \text{A}, \text{dI/dt} = 100 \text{A/}\mu\text{s}^b$		-	0.65	1.3	μC
Forward turn-on time	t _{on}	Intrinsic tu	n-on is dominated by L _S and L _D)			L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

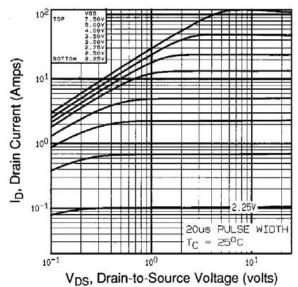


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

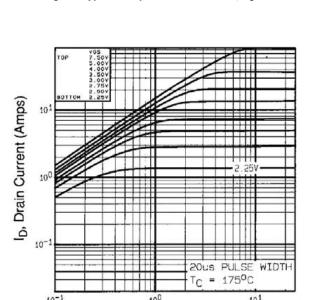


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

V_{DS}, Drain-to-Source Voltage (volts)

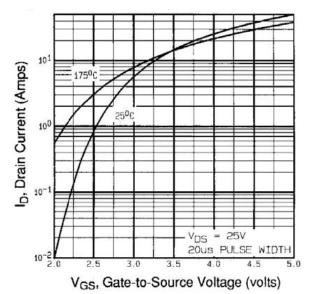


Fig. 3 - Typical Transfer Characteristics

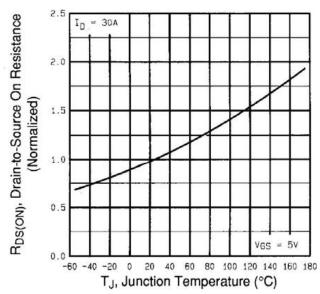


Fig. 4 - Normalized On-Resistance vs. Temperature



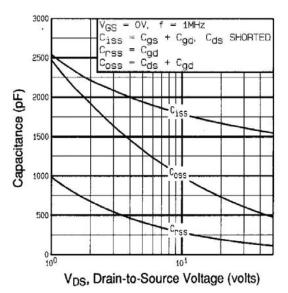


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

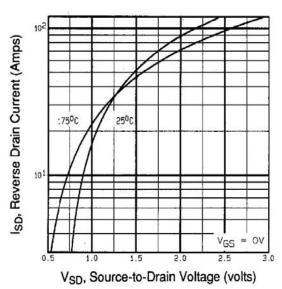


Fig. 7 - Typical Source-Drain Diode Forward Voltage

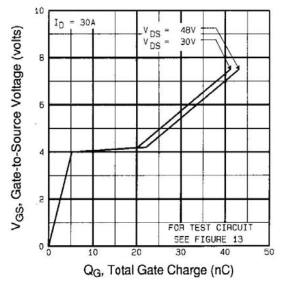


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

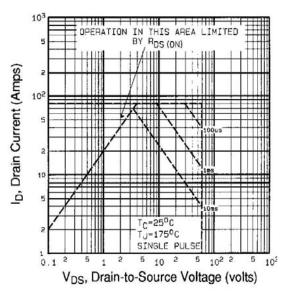


Fig. 8 - Maximum Safe Operating Area



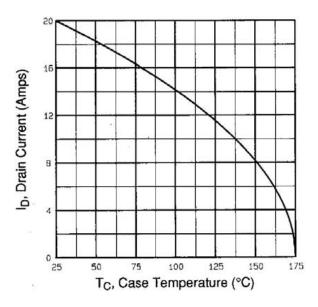


Fig. 9 - Maximum Drain Current vs. Case Temperature

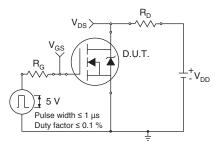


Fig. 10a - Switching Time Test Circuit

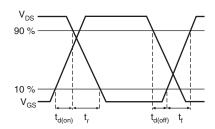


Fig. 10b - Switching Time Waveforms

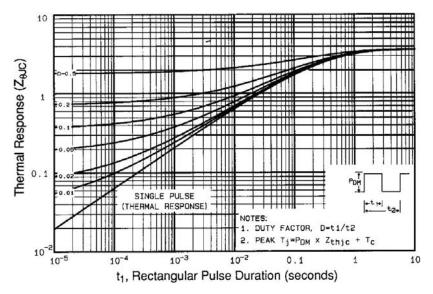
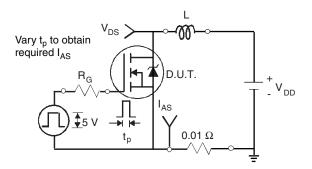


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case





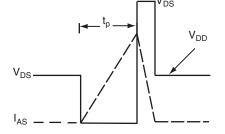


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

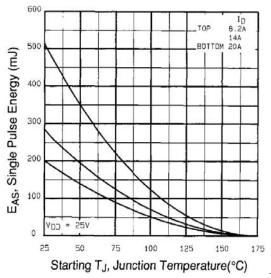


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

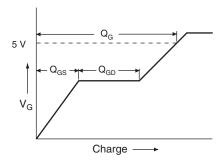


Fig. 13a - Basic Gate Charge Waveform

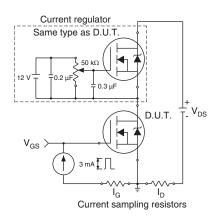
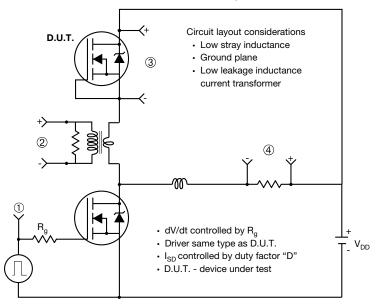


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



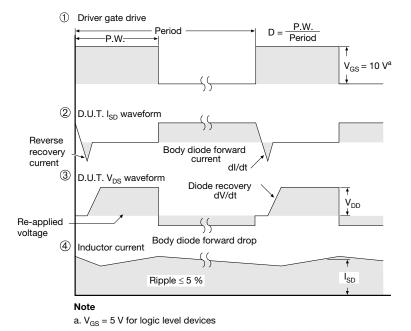


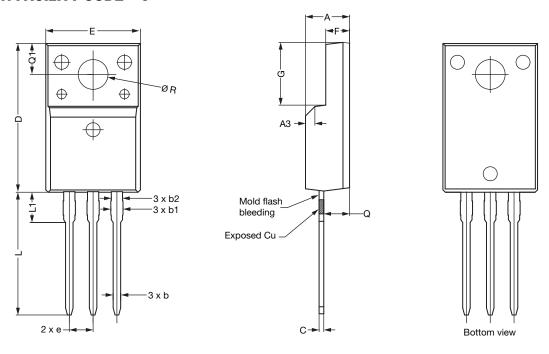
Fig. 14 - For N-Channel

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TO-220 FULLPAK (High Voltage)

OPTION 1: FACILITY CODE = 9



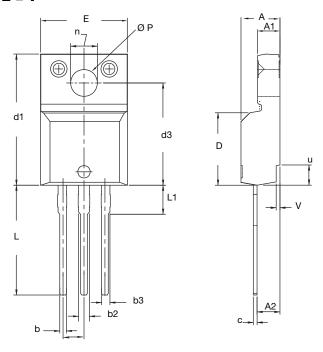
	MILLIMETERS		
DIM.	MIN.	NOM.	MAX.
Α	4.60	4.70	4.80
b	0.70	0.80	0.91
b1	1.20	1.30	1.47
b2	1.10	1.20	1.30
С	0.45	0.50	0.63
D	15.80	15.87	15.97
е		2.54 BSC	
E	10.00	10.10	10.30
F	2.44	2.54	2.64
G	6.50	6.70	6.90
L	12.90	13.10	13.30
L1	3.13	3.23	3.33
Q	2.65	2.75	2.85
Q1	3.20	3.30	3.40
ØR	3.08	3.18	3.28

Notes

- 1. To be used only for process drawing
- 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads
- 3. All critical dimensions should C meet $C_{pk} > 1.33$
- 4. All dimensions include burrs and plating thickness
- 5. No chipping or package damage
- 6. Facility code will be the 1st character located at the 2nd row of the unit marking



OPTION 2: FACILITY CODE = Y



	MILLIMETERS		INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.570	4.830	0.180	0.190	
A1	2.570	2.830	0.101	0.111	
A2	2.510	2.850	0.099	0.112	
b	0.622	0.890	0.024	0.035	
b2	1.229	1.400	0.048	0.055	
b3	1.229	1.400	0.048	0.055	
С	0.440	0.629	0.017	0.025	
D	8.650	9.800	0.341	0.386	
d1	15.88	16.120	0.622	0.635	
d3	12.300	12.920	0.484	0.509	
E	10.360	10.630	0.408	0.419	
е	2.54	2.54 BSC		0.100 BSC	
L	13.200	13.730	0.520	0.541	
L1	3.100	3.500	0.122	0.138	
n	6.050	6.150	0.238	0.242	
ØP	3.050	3.450	0.120	0.136	
u	2.400	2.500	0.094	0.098	
V	0.400	0.500	0.016	0.020	

ECN: E19-0180-Rev. D, 08-Apr-2019

DWG: 5972

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- 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads
- 3. All critical dimensions should C meet $C_{pk} > 1.33$
- 4. All dimensions include burrs and plating thickness
- 5. No chipping or package damage
- 6. Facility code will be the 1st character located at the 2nd row of the unit marking



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Vishay

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